

**Search Notes**

Application/Control No.

09/757,006

Examiner

Le Nguyen

Applicant(s)/Patent under  
Reexamination

GEIER ET AL.

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted w/Vincent Trans	9/14/2006	LVN
consulted w/Tod Swann	9/15/2006	LVN
<a href="http://www.netlibrary.com/">http://www.netlibrary.com/</a>	9/27/2006	LVN